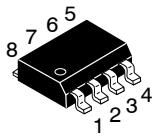
MOSFET – N-Channel, POWERTRENCH®

150 V, 4.1 A, 66 mΩ

FDS2582

V_{DSS} MAX	$R_{DS(on)}$ MAX	I_D MAX
150 V	66 mΩ @ 10 V	4.1 A



SOIC8
(SO−8)
CASE 751EB

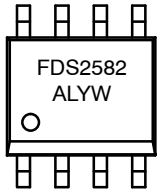
Features

- $R_{DS(on)}$ = 57 mΩ (Typ.), V_{GS} = 10 V, I_D = 4.1 A
- $Q_{g(TOT)}$ = 19 nC (Typ.), V_{GS} = 10 V
- Low Miller Charge
- Low Q_{RR} Body Diode
- Optimized Efficiency at High Frequencies
- UIS Capability (Single Pulse and Repetitive Pulse)
- This Device is Pb−Free and Halide free

Applications

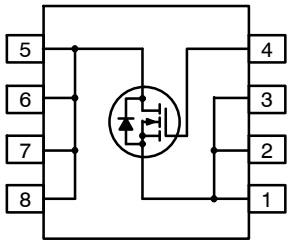
- DC/DC Converters and Off−Line UPS
- Distributed Power Architectures and VRMs
- Primary Switch for 24 V and 48 V Systems
- High Voltage Synchronous Rectifier
- Direct Injection / Diesel Injection Systems
- 42 V Automotive Load Control
- Electronic Valve Train Systems

MARKING DIAGRAM



FDS2582 = Device Code
A = Assembly Site
L = Wafer Lot Number
YW = Assembly Start Week

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information on page 13 of this data sheet.

MOSFET MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Symbol	Parameter		Ratings	Unit
V_{DSS}	Drain to Source Voltage		150	V
V_{GS}	Gate to Source Voltage		±20	V
I_D	Drain Current	Continuous (T_A = 25°C, V_{GS} = 10 V, $R_{\theta JA}$ = 50°C/W)	4.1	A
		Continuous (T_A = 100°C, V_{GS} = 10 V, $R_{\theta JA}$ = 50°C/W)	2.6	A
		Pulsed	Figure 4	A
E_{AS}	Single Pulse Avalanche Energy (Note 1)		252	mJ
P_D	Power Dissipation		2.5	W
	Derate above 25°C		20	mW/°C
T_J, T_{STG}	Operating and Storage Temperature		−55 to 150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Starting T_J = 25°C, L = 56 mH, I_{AS} = 3 A.

© Semiconductor Components Industries, LLC, 2002

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient at 10 seconds (Note 3)	50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient at 1000 seconds (Note 3)	80	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case (Note 2)	25	°C/W

2. $R_{\theta JA}$ is the sum of the junction−to−case and case−to−ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.
3. $R_{\theta JA}$ is measured with 1.0 in^2 copper on FR−4 board.

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
B_{VDSS}	Drain to Source Breakdown Voltage	I_D = 250 μA, V_{GS} = 0 V	150	–	–	V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 120 V, V_{GS} = 0 V	–	–	1	μA
		V_{DS} = 120 V, V_{GS} = 0 V, T_C = 150°C	–	–	250	
I_{GSS}	Gate to Source Leakage Current	V_{GS} = ±20 V	–	–	±100	nA
ON CHARACTERISTICS						
$V_{GS(TH)}$	Gate to Source Threshold Voltage	V_{GS} = V_{DS}, I_D = 250 μA	2	–	4	V
$R_{DS(on)}$	Drain to Source On Resistance	I_D = 4.1 A, V_{GS} = 10 V	–	57	66	mΩ
		I_D = 2 A, V_{GS} = 6 V	–	65	98	
		I_D = 4.1 A, V_{GS} = 10 V, T_C = 150°C	–	125	146	
DYNAMIC CHARACTERISTICS						
C_{ISS}	Input Capacitance	V_{DS} = 25 V, V_{GS} = 0 V, f = 1 MHz	–	1290	–	pF
C_{OSS}	Output Capacitance		–	150	–	pF
C_{RSS}	Reverse Transfer Capacitance		–	32	–	pF
$Q_{g(TOT)}$	Total Gate Charge at 10 V	V_{GS} = 0 V to 10 V, V_{DD} = 75 V, I_D = 4.1 A, I_g = 1.0 mA	–	19	25	nC
$Q_{g(TH)}$	Threshold Gate Charge	V_{GS} = 0 V to 2 V, V_{DD} = 75 V, I_D = 4.1 A, I_g = 1.0 mA	–	2.3	3.0	nC
Q_{gs}	Gate to Source Gate Charge	V_{DD} = 75 V, I_D = 4.1 A, I_g = 1.0 mA	–	5.4	–	nC
Q_{gs2}	Gate Charge Threshold to Plateau		–	3.1	–	nC
Q_{gd}	Gate to Drain "Miller" Charge		–	4.4	–	nC
RESISTIVE SWITCHING CHARACTERISTICS (V_{GS} = 10 V)						
t_{ON}	Turn−On Time	V_{DD} = 75 V, I_D = 4.1 A, V_{GS} = 10 V, R_{GS} = 16 Ω	–	–	45	ns
$t_{d(ON)}$	Turn−On Delay Time		–	11	–	ns
t_r	Rise Time		–	19	–	ns
$t_{d(OFF)}$	Turn−Off Delay Time		–	36	–	ns
t_f	Fall Time		–	26	–	ns
t_{OFF}	Turn−Off Time		–	–	92	ns
DRAIN−SOURCE DIODE CHARACTERISTICS						
V_{SD}	Source to Drain Diode Voltage	I_{SD} = 4.1 A	–	–	1.25	V
		I_{SD} = 2 A	–	–	1.0	V
t_{rr}	Reverse Recovery Time	I_{SD} = 4.1 A, dI_{SD}/dt = 100 A/μs	–	–	63	ns
Q_{RR}	Reverse Recovered Charge	I_{SD} = 4.1 A, dI_{SD}/dt = 100 A/μs	–	–	116	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

(T_A = 25°C unless otherwise noted)

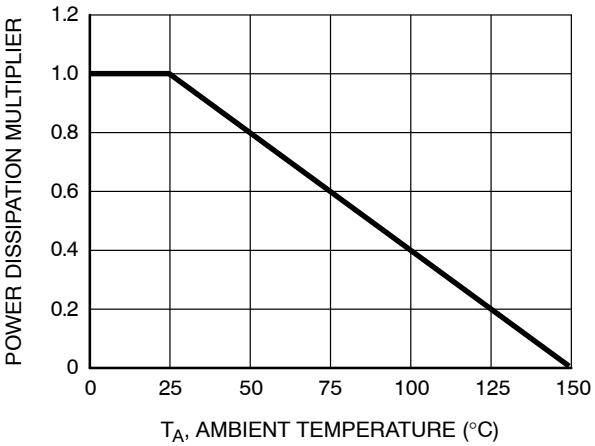


Figure 1. Normalized Power Dissipation vs. Ambient Temperature

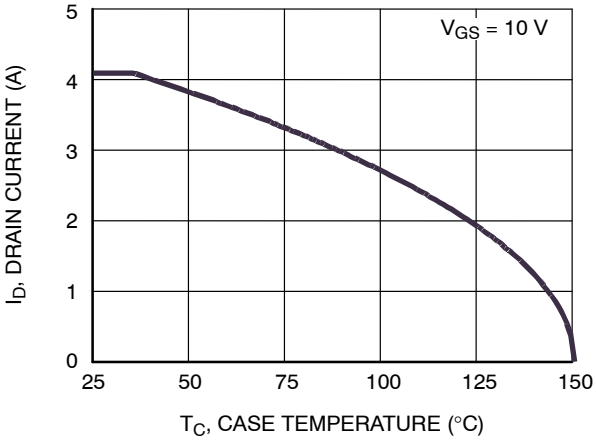


Figure 2. Maximum Continuous Drain Current vs. Case Temperature

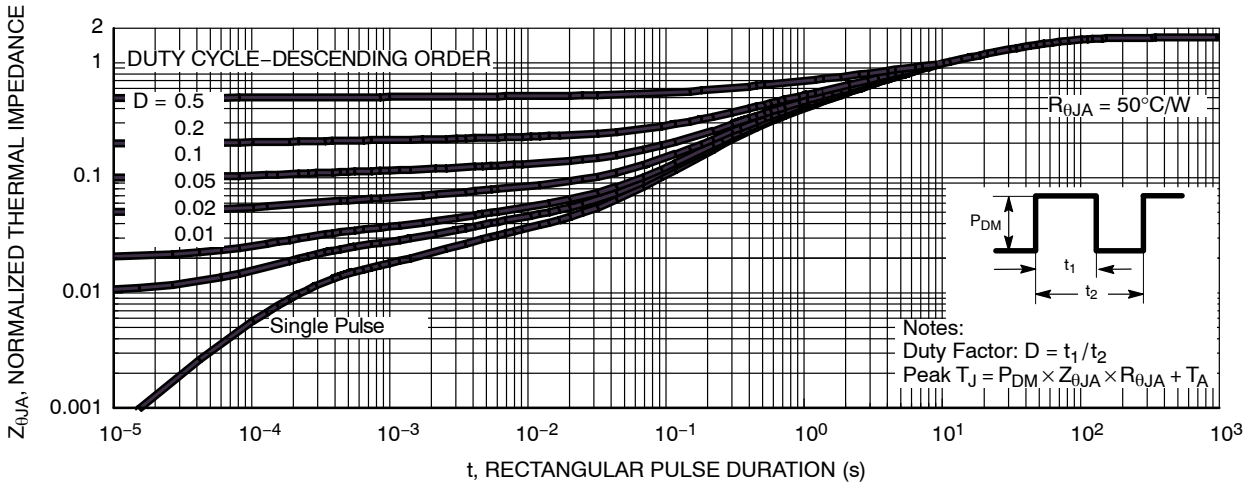


Figure 3. Normalized Maximum Transient Thermal Impedance

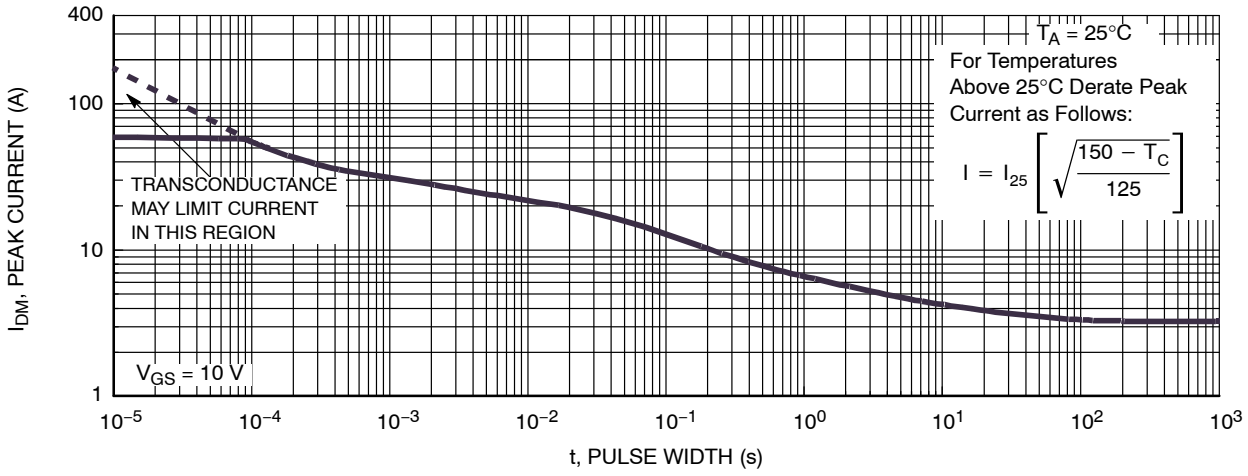


Figure 4. Peak Current Capability

TYPICAL CHARACTERISTICS

(T_A = 25°C unless otherwise noted) (continued)

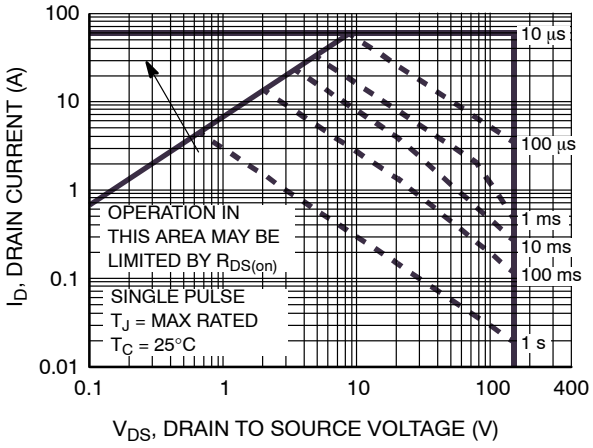
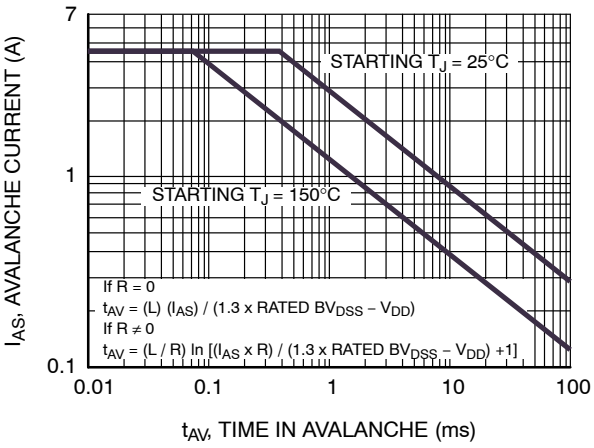


Figure 5. Forward Bias Safe Operating Area



NOTE: Refer to **onsemi** Application Notes AN−7514 and AN−7515

Figure 6. Unclamped Inductive Switching Capability

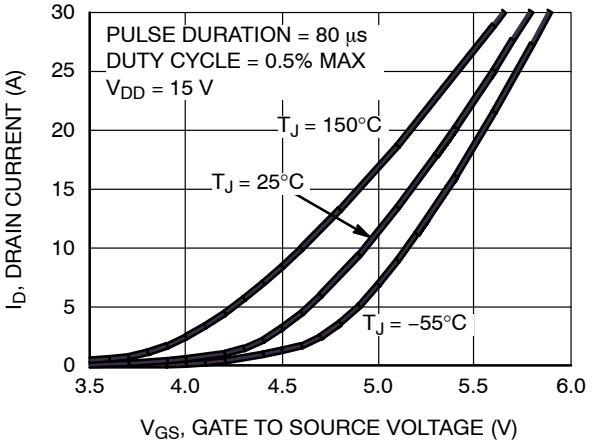


Figure 7. Transfer Characteristics

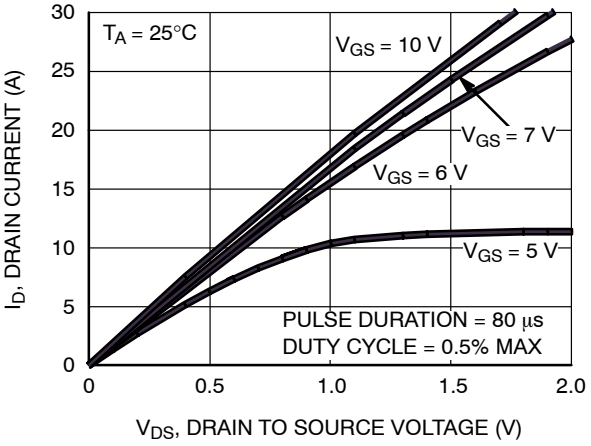


Figure 8. Saturation Characteristics

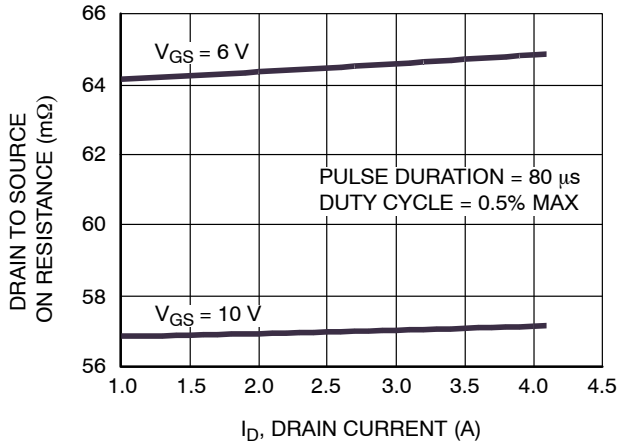


Figure 9. Drain to Source On Resistance vs. Drain Current

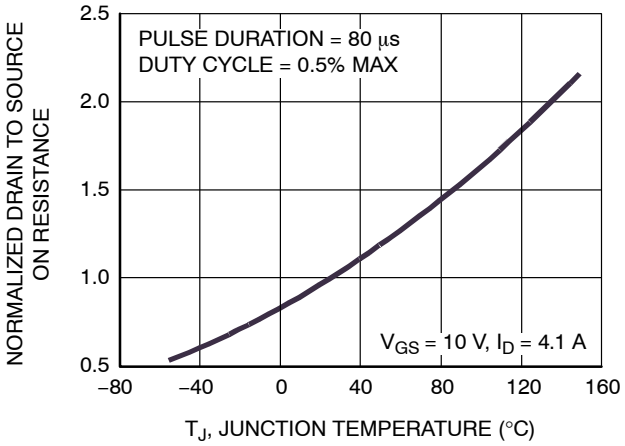


Figure 10. Normalized Drain to Source On Resistance vs. Junction Temperature

TYPICAL CHARACTERISTICS

(T_A = 25°C unless otherwise noted) (continued)

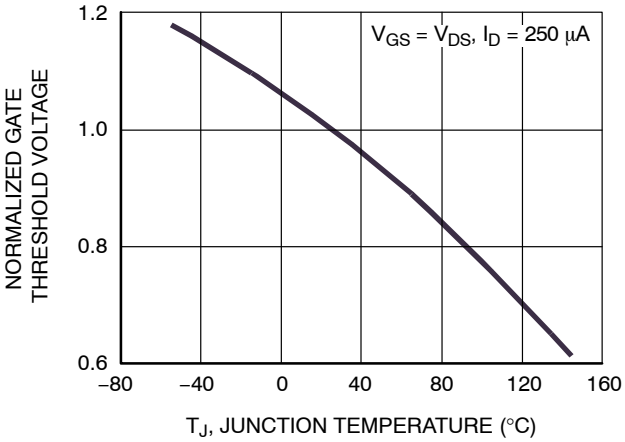


Figure 11. Normalized Gate Threshold Voltage vs. Junction Temperature

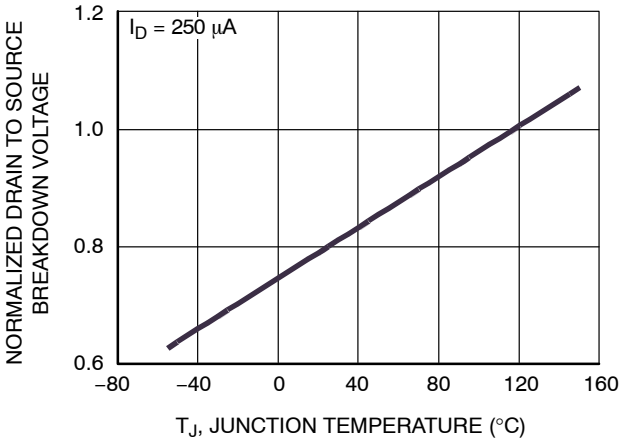


Figure 12. Normalized Drain to Source Breakdown Voltage vs. Junction Temperature

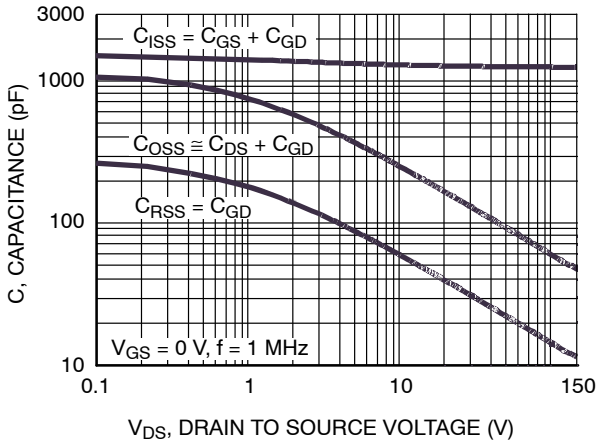


Figure 13. Capacitance vs. Drain to Source Voltage

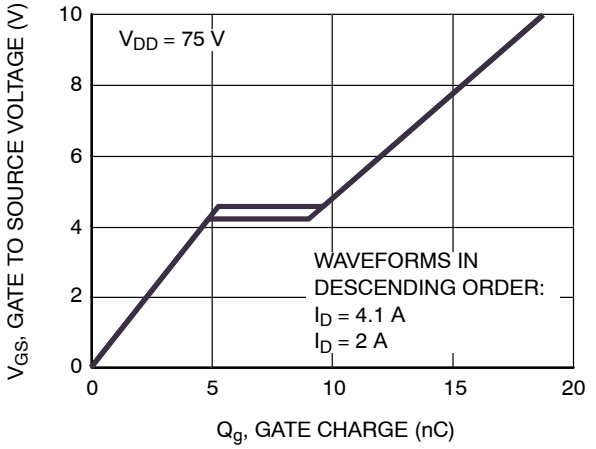


Figure 14. Gate Charge Waveforms for Constant Gate Currents

TEST CIRCUITS AND WAVEFORMS

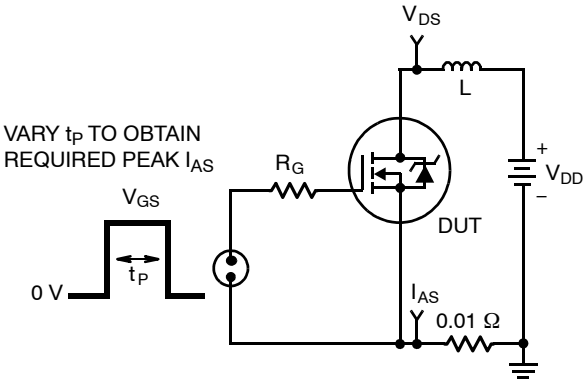


Figure 15. Unclamped Energy Test Circuit

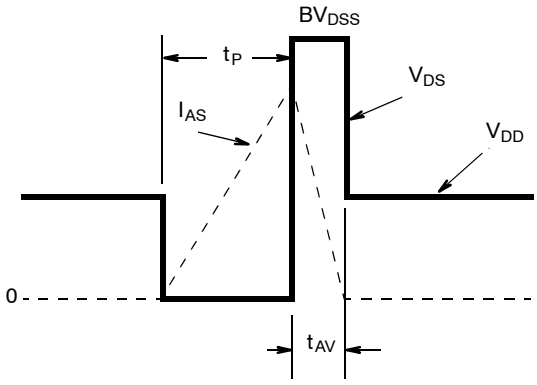


Figure 16. Unclamped Waveforms

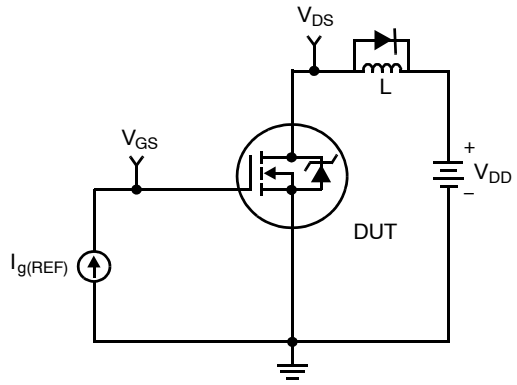


Figure 17. Gate Charge Test Circuit

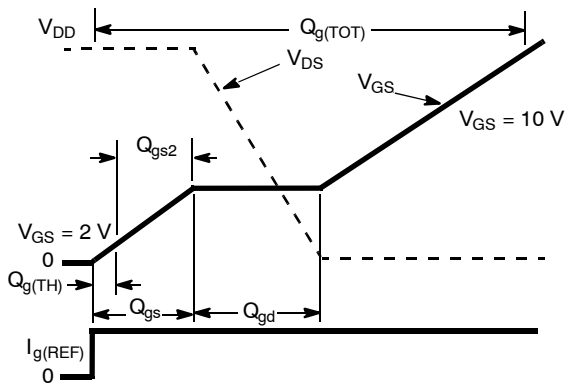


Figure 18. Gate Charge Waveforms

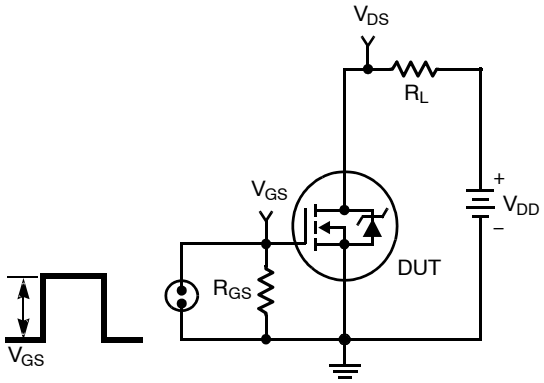


Figure 19. Switching Time Test Circuit

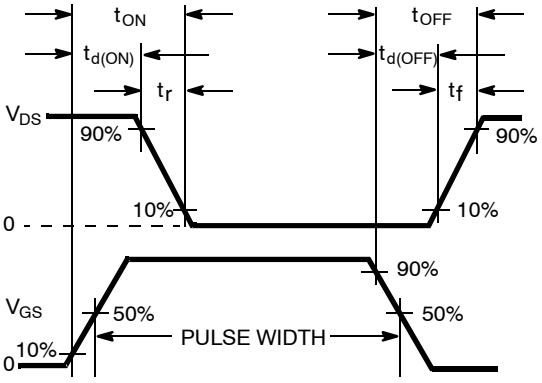


Figure 20. Switching Time Waveforms

THERMAL RESISTANCE VS. MOUNTING PAD AREA

The maximum rated junction temperature, T_{JM}, and the thermal resistance of the heat dissipating path determines the maximum allowable device power dissipation, P_{DM}, in an application. Therefore the application's ambient temperature, T_A (°C), and thermal resistance $R_{\theta JA}$ (°C/W) must be reviewed to ensure that T_{JM} is never exceeded. Equation 1 mathematically represents the relationship and serves as the basis for establishing the rating of the part.

$$P_{DM} = \frac{(T_{JM} - T_A)}{R_{\theta JA}} \quad \text{(eq. 1)}$$

In using surface mount devices such as the SO8 package, the environment in which it is applied will have a significant influence on the part's current and maximum power dissipation ratings. Precise determination of P_{DM} is complex and influenced by many factors:

1. Mounting pad area onto which the device is attached and whether there is copper on one side or both sides of the board.
2. The number of copper layers and the thickness of the board.
3. The use of external heat sinks.
4. The use of thermal vias.
5. Air flow and board orientation.
6. For non steady state applications, the pulse width, the duty cycle and the transient thermal response of the part, the board and the environment they are in.

onsemi provides thermal information to assist the designer's preliminary application evaluation. Figure 21 defines the $R_{\theta JA}$ for the device as a function of the top copper (component side) area. This is for a horizontally positioned FR−4 board with 1 oz copper after 1000 seconds of steady state power with no air flow. This graph provides the necessary information for calculation of the steady state junction temperature or power dissipation. Pulse applications can be evaluated using the **onsemi** device Spice thermal model or manually utilizing the normalized maximum transient thermal impedance curve.

Thermal resistances corresponding to other copper areas can be obtained from Figure 21 or by calculation using Equation 2. The area, in square inches is the top copper area including the gate and source pads.

$$R_{\theta JA} = 64 + \frac{26}{0.23 + \text{Area}} \quad \text{(eq. 2)}$$

The transient thermal impedance ($Z_{\theta JA}$) is also effected by varied top copper board area. Figure 22 shows the effect of copper pad area on single pulse transient thermal impedance. Each trace represents a copper pad area in square inches corresponding to the descending list in the graph. Spice and SABER thermal models are provided for each of the listed pad areas.

Copper pad area has no perceivable effect on transient thermal impedance for pulse widths less than 100 ms. For pulse widths less than 100 ms the transient thermal impedance is determined by the die and package. Therefore, CTHERM1 through CTHERM5 and RTHERM1 through RTHERM5 remain constant for each of the thermal models. A listing of the model component values is available in Table 1.

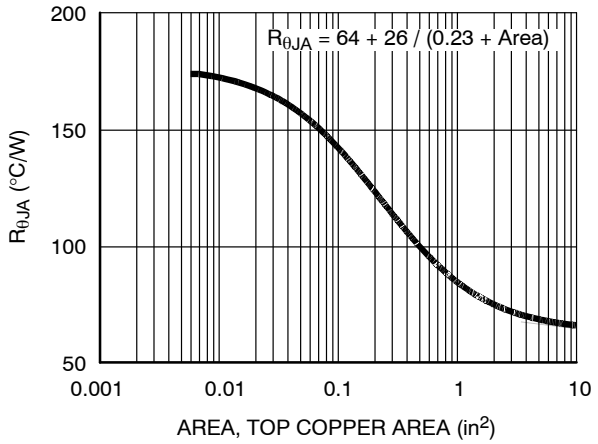


Figure 21. Thermal Resistance vs. Mounting Pad Area

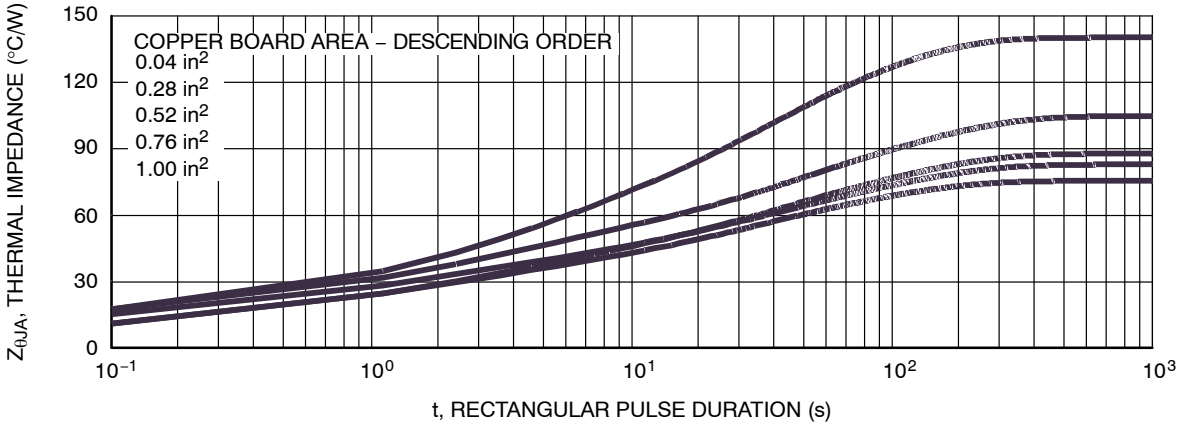


Figure 22. Thermal Impedance vs. Mounting Pad Area

PSPICE ELECTRICAL MODEL

.SUBCKT FDS2582 2 1 3; rev July 2002

Ca 12 8 4.5e−10
Cb 15 14 5.0e−10
Cin 6 8 1.25e−9

Dbody 7 5 DbodyMOD
Dbreak 5 11 DbreakMOD
Dplcap 10 5 DplcapMOD

Ebreak 11 7 17 18 155.5
Eds 14 8 5 8 1
Egs 13 8 6 8 1
Esg 6 10 6 8 1
Evthres 6 21 19 8 1
Evtemp 20 6 18 22 1

It 8 17 1

Lgate 1 9 5.61e−9
Ldrain 2 5 1e−9
Lsource 3 7 1.98e−9

RLgate 1 9 56.1
RLdrain 2 5 10
RLsource 3 7 19.8

Mmed 16 6 8 8 MmedMOD
Mstro 16 6 8 8 MstroMOD
Mweak 16 21 8 8 MweakMOD

Rbreak 17 18 RbreakMOD 1
Rdrain 50 16 RdrainMOD 30.0e−3
Rgate 9 20 1.5
RSLC1 5 51 RSLCMOD 1e−6
RSLC2 5 50 1e3
Rsource 8 7 RsourceMOD 20.0e−3
Rvthres 22 8 RvthresMOD 1
Rvtemp 18 19 RvtempMOD 1
S1a 6 12 13 8 S1AMOD
S1b 13 12 13 8 S1BMOD
S2a 6 15 14 13 S2AMOD
S2b 13 15 14 13 S2BMOD

Vbat 22 19 DC 1

ESLC 51 50 VALUE={(V(5,51)/ABS(V(5,51)))*(PWR(V(5,51)/(1e−6*60),2.5))}

.MODEL DbodyMOD D (IS=2.4E−12 N=1.0 RS=10.0e−3 TRS1=2.1e−3 TRS2=4.7e−7
+CJO=9.0e−10 M=0.64 TT=3.9e−8 XTI=4.6)
.MODEL DbreakMOD D (RS=1.0 TRS1=1.4e−3 TRS2=−5e−5)
.MODEL DplcapMOD D (CJO=2.8e−10 IS=1e−30 N=10 M=0.64)

.MODEL MmedMOD NMOS (VTO=3.5 KP=4.0 IS=1e−30 N=10 TOX=1 L=1u W=1u RG=1.5)
.MODEL MstroMOD NMOS (VTO=4.2 KP=50 IS=1e−30 N=10 TOX=1 L=1u W=1u)
.MODEL MweakMOD NMOS (VTO=2.92 KP=0.04 IS=1e−30 N=10 TOX=1 L=1u W=1u RG=15 RS=0.1)

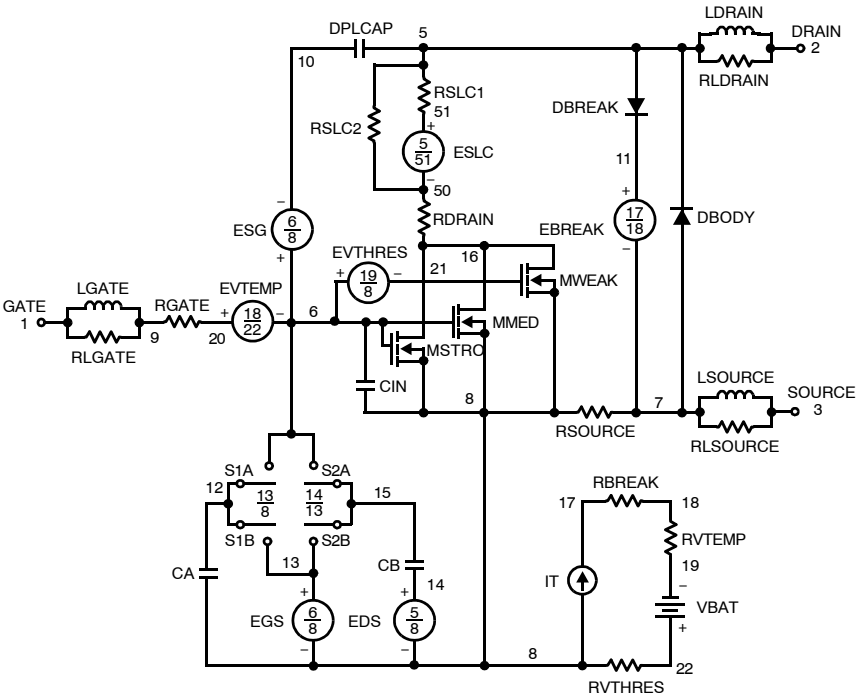


Figure 23.

.MODEL RbreakMOD RES (TC1=1.1e−3 TC2=−1.0e−8)
.MODEL RdrainMOD RES (TC1=1.15e−2 TC2=3.0e−5)
.MODEL RSLCMOD RES (TC1=4.4e−3 TC2=2.9e−6)
.MODEL RsourceMOD RES (TC1=1e−3 TC2=1e−6)
.MODEL RvthresMOD RES (TC1=−3.9e−3 TC2=−1.6e−5)
.MODEL RvtempMOD RES (TC1=−3.5e−3 TC2=1.5e−6)

.MODEL S1AMOD VSWITCH (RON=1e−5 ROFF=0.1 VON=−3.0 VOFF=−2.0)
.MODEL S1BMOD VSWITCH (RON=1e−5 ROFF=0.1 VON=−2.0 VOFF=−3.0)
.MODEL S2AMOD VSWITCH (RON=1e−5 ROFF=0.1 VON=−1.5 VOFF=1.0)
.MODEL S2BMOD VSWITCH (RON=1e−5 ROFF=0.1 VON=1.0 VOFF=−1.5)

.ENDS

NOTE: For further discussion of the PSPICE model, consult **A New PSPICE Sub−Circuit for the Power MOSFET Featuring Global Temperature Options**; IEEE Power Electronics Specialist Conference Records, 1991, written by William J. Hepp and C. Frank Wheatley.

SABER ELECTRICAL MODEL

```
REV July 2002
template FDS2582 n2,n1,n3
electrical n2,n1,n3
{
var i iscl
dp..model dbodymod = (isl=2.4e−12,nl=1.0,rs=10.0e−3,trs1=2.1e−3,trs2=4.7e−7,cjo=9.0e−10,m=0.64,tt=3.9e−8,xti=4.6)
dp..model dbreakmod = (rs=1.0,trs1=1.4e−3,trs2=−5e−5)
dp..model dplcapmod = (cjo=2.8e−10,isl=10e−30,nl=10,m=0.64)
m..model mmedmod = (type=_n,vto=3.5,kp=4.0,is=1e−30, tox=1)
m..model mstrongmod = (type=_n,vto=4.2,kp=50,is=1e−30, tox=1)
m..model mweakmod = (type=_n,vto=2.92,kp=0.04,is=1e−30, tox=1,rs=0.1)
sw_vcsp..model s1amod = (ron=1e−5,roff=0.1,von=−3.0,voff=−2.0)
sw_vcsp..model s1bmod = (ron=1e−5,roff=0.1,von=−2.0,voff=−3.0)
sw_vcsp..model s2amod = (ron=1e−5,roff=0.1,von=−1.5,voff=1.0)
sw_vcsp..model s2bmod = (ron=1e−5,roff=0.1,von=1.0,voff=−1.5)
c.ca n12 n8 = 4.5e−10
c.cb n15 n14 = 5.0e−10
c.cin n6 n8 = 1.25e−9

dp.dbody n7 n5 = model=dbodymod
dp.dbreak n5 n11 = model=dbreakmod
dp.dplcap n10 n5 = model=dplcapmod

spe.ebreak n11 n7 n17 n18 = 155.5
spe.eds n14 n8 n5 n8 = 1
spe.egs n13 n8 n6 n8 = 1
spe.esg n6 n10 n6 n8 = 1
spe.evthres n6 n21 n19 n8 = 1
spe.evtemp n20 n6 n18 n22 = 1

i.it n8 n17 = 1

l.lgate n1 n9 = 5.61e−9
l.ldrain n2 n5 = 1e−9
l.lsource n3 n7 = 1.98e−9

res.rlgate n1 n9 = 56.1
res.rldrain n2 n5 = 10
res.rlsource n3 n7 = 19.8

m.mmed n16 n6 n8 n8 = model=mmedmod, l=1u, w=1u
m.mstrong n16 n6 n8 n8 = model=mstrongmod, l=1u, w=1u
m.mweak n16 n21 n8 n8 = model=mweakmod, l=1u, w=1u

res.rbreak n17 n18 = 1, tc1=1.1e−3,tc2=−1.0e−8
res.rdrain n50 n16 = 30.0e−3, tc1=1.15e−2,tc2=3.0e−5
res.rgate n9 n20 = 1.5
res.rslc1 n5 n51 = 1e−6, tc1=4.4e−3,tc2=2.9e−6
res.rslc2 n5 n50 = 1e3
res.rsource n8 n7 = 20.0e−3, tc1=1e−3,tc2=1e−6
res.rvthres n22 n8 = 1, tc1=−3.9e−3,tc2=−1.6e−5
res.rvtemp n18 n19 = 1, tc1=−3.5e−3,tc2=1.5e−6
sw_vcsp.s1a n6 n12 n13 n8 = model=s1amod
sw_vcsp.s1b n13 n12 n13 n8 = model=s1bmod
sw_vcsp.s2a n6 n15 n14 n13 = model=s2amod
sw_vcsp.s2b n13 n15 n14 n13 = model=s2bmod
```

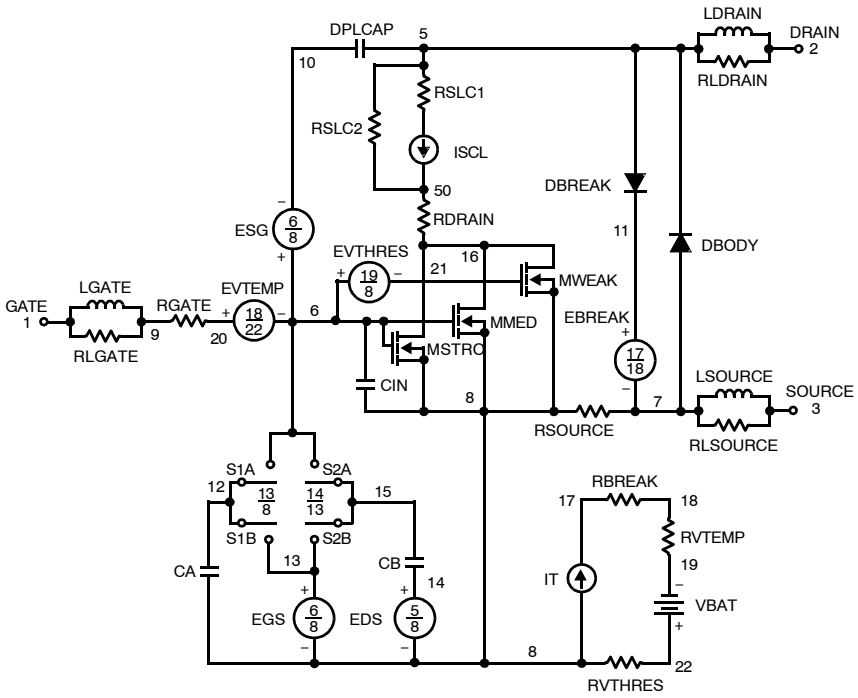


Figure 24.

```
v.vbat n22 n19 = dc=1
equations {
i (n51−>n50) +=iscl
iscl: v(n51,n50) = ((v(n5,n51)/(1e−9+abs(v(n5,n51))))*((abs(v(n5,n51)*1e6/60))** 2.5))
}
}
```

SPICE THERMAL MODEL

REV July 2002
FDS2582
Copper Area =1.0 in^2
CTHERM1 TH 8 4e−4
CTHERM2 8 7 5e−3
CTHERM3 7 6 6e−2
CTHERM4 6 5 9e−2
CTHERM5 5 4 3e−1
CTHERM6 4 3 4e−1
CTHERM7 3 2 9e−1
CTHERM8 2 TL 2

RTHERM1 TH 8 5e−1
RTHERM2 8 7 6e−1
RTHERM3 7 6 4
RTHERM4 6 5 5
RTHERM5 5 4 8
RTHERM6 4 3 9
RTHERM7 3 2 15
RTHERM8 2 TL 23

SABER THERMAL MODEL

Copper Area = 1.0 in^2
template thermal_model th tl
thermal_c th, tl
{
CTHERM1 TH 8 4e−4
CTHERM2 8 7 5e−3
CTHERM3 7 6 6e−2
CTHERM4 6 5 9e−2
CTHERM5 5 4 3e−1
CTHERM6 4 3 4e−1
CTHERM7 3 2 9e−1
CTHERM8 2 TL 2

RTHERM1 TH 8 5e−1
RTHERM2 8 7 6e−1
RTHERM3 7 6 4
RTHERM4 6 5 5
RTHERM5 5 4 8
RTHERM6 4 3 9
RTHERM7 3 2 15
RTHERM8 2 TL 23
}

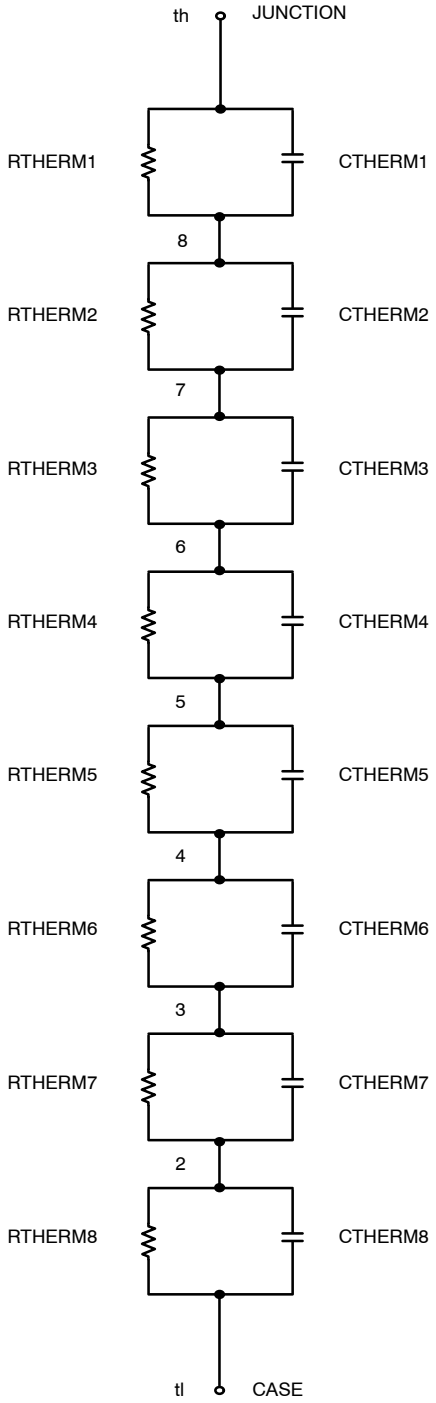


Figure 25.

Table 1. THERMAL MODES

COMPONANT	0.04 in^2	0.28 in^2	0.52 in^2	0.76 in^2	1.0 in^2
CTHERM6	3.2e−1	3.5e−1	4.0e−1	4.0e−1	4.0e−1
CTHERM7	8.5e−1	9.0e−1	9.0e−1	9.0e−1	9.0e−1
CTHERM8	0.3	1.8	2.0	2.0	2.0
RTHERM6	24	18	12	10	9
RTHERM7	36	21	18	16	15
RTHERM8	53	37	30	28	23

PACKAGE MARKING AND ORDERING INFORMATION

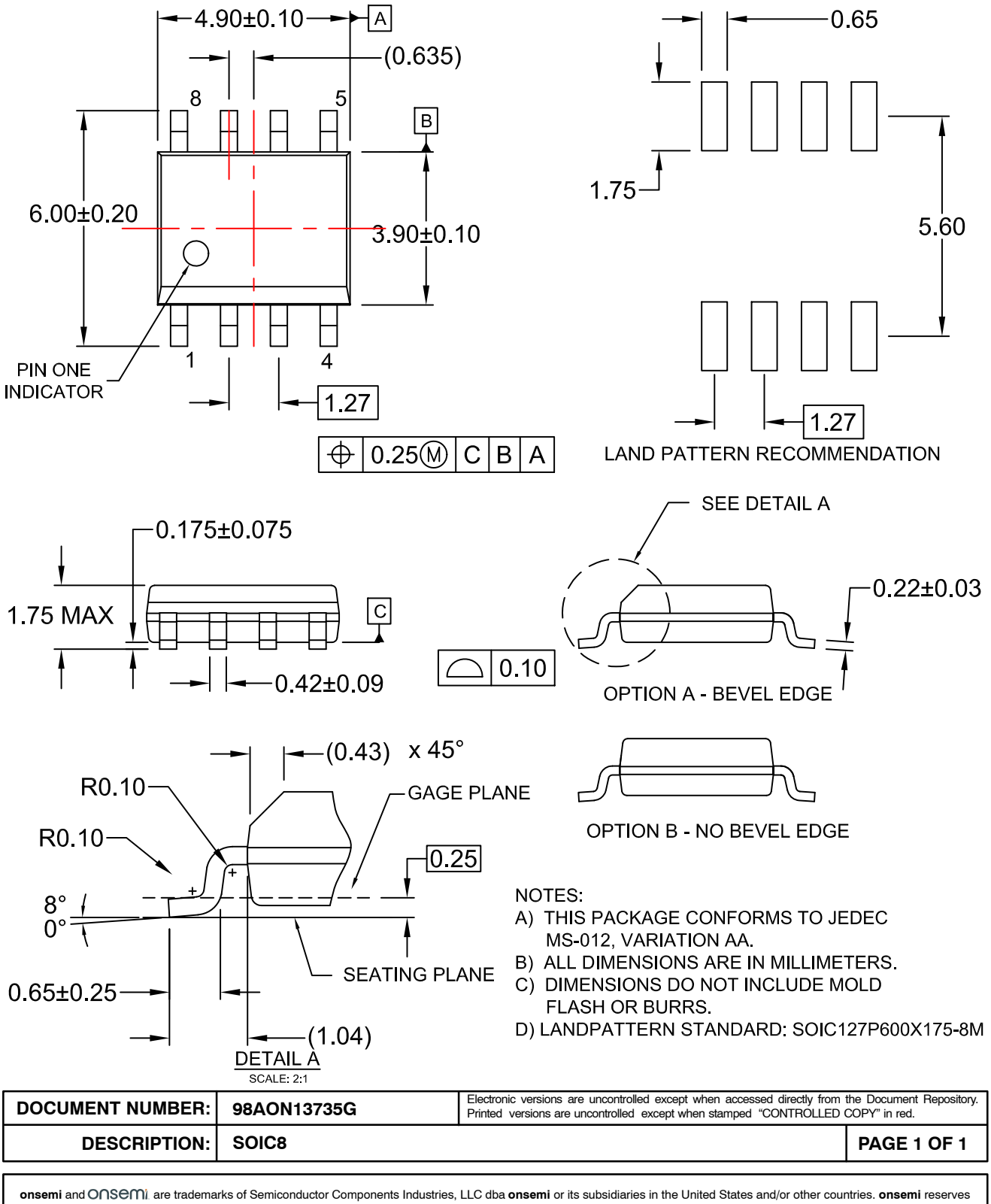
Device	Device Marking	Package Type	Reel Size	Tape Width	Shipping†
FDS2582	FDS2582	SOIC8 (SO−8) (Pb−Free)	330 mm	12 mm	2500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

POWERTRENCH is registered trademark of Semiconductor Components Industries, LLC dba “**onsemi**” or its affiliates and/or subsidiaries in the United States and/or other countries.

SOIC8
CASE 751EB
ISSUE A

DATE 24 AUG 2017



NOTES:
A) THIS PACKAGE CONFORMS TO JEDEC MS-012, VARIATION AA.
B) ALL DIMENSIONS ARE IN MILLIMETERS.
C) DIMENSIONS DO NOT INCLUDE MOLD FLASH OR BURRS.
D) LANDPATTERN STANDARD: SOIC127P600X175-8M

DOCUMENT NUMBER:	**98AON13735G**	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.
DESCRIPTION:	**SOIC8**	**PAGE 1 OF 1**

onsemi and onsemi are trademarks of Semiconductor Components Industries, LLC dba **onsemi** or its subsidiaries in the United States and/or other countries. **onsemi** reserves the right to make changes without further notice to any products herein. **onsemi** makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. **onsemi** does not convey any license under its patent rights nor the rights of others.

onsemi, , and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "**onsemi**" or its affiliates and/or subsidiaries in the United States and/or other countries. **onsemi** owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of **onsemi**'s product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent−Marking.pdf. **onsemi** reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as−is" and **onsemi** makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:
Technical Library: www.onsemi.com/design/resources/technical−documentation
onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support
For additional information, please contact your local Sales Representative at www.onsemi.com/support/sales

ENTEGRECİ

Bu belge www.entegreci.com üzerinden sunulmaktadır.

Elektronik komponent tedarikinde Entegreci

Entegreci, Eskişehir merkezli, Türkiye geneline satış yapan bir elektronik komponent mağazasıdır. Entegreler (IC), mikrodenetleyiciler, transistörler, diyotlar, pasif elemanlar, konnektörler, modüller ve geliştirme kartları tek adetten seri üretim adetlerine kadar satılır. Ürün sayfalarında güncel stok durumunu, fiyatı ve datasheet bağlantısını bulabilirsiniz.

Parça koduyla arama

Üretici parça numarasını yazın; stok ve fiyatı hemen görün.

www.entegreci.com

Ürün kategorileri

Entegreden kapasitöre tüm elektronik komponent kategorileri.

Kategorilere göz atın

Üreticiler

Aradığınız üreticinin ürünlerini tek sayfada inceleyin.

Üreticileri görün

Toplu alım ve teklif

Listede olmayan ya da yüksek adetli parçalar için teklif isteyin.

Teklif isteyin

www.entegreci.com | **destek@entegreci.com** | **0850 305 90 34**

Entegreci is an online electronic components store based in Türkiye. Search by manufacturer part number to see stock, prices and datasheets for integrated circuits, microcontrollers, transistors, passive components and connectors, or request a quote for parts that are not listed.

Bu sayfa Entegreci tarafından eklenmiştir. Belgenin önceki sayfaları asıl yayıncısına aittir ve içeriği değiştirilmemiştir; en güncel sürüm için belgenin yayıncısına başvurun.